

Notice of References Cited	Application/Control No. 10/823,664	Applicant(s)/Patent Under Reexamination AKASAKI ET AL.	
	Examiner VanThu Nguyen	Art Unit 2824	Page 1 of 1

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* :		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,108,266	08-2000	Weier et al.	365/230.08
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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